



700V N-CHANNEL ENHANCEMENT MODE MOSFET

Product Summary

BV _{DSS}	R _{DS(ON)} Max	I _D T _C = +25°C
700V	$1.25\Omega @ V_{GS} = 10V$	3.9A

Features

- 100% Unclamped Inductive Switch (UIS) Test in Production
- Low Gate Input Resistance
- Low Input Capacitance
- Lead-Free Finish; RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)

Description

This new generation MOSFET is designed to minimize the on-state resistance (R_{DS(ON)}) and yet maintain superior switching performance, making it ideal for high-efficiency power management applications.

Mechanical Data

- Case: TO252 (DPAK)
- Case Material: Molded Plastic, "Green" Molding Compound.
 UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminal Connections: See Diagram
- Terminals: Finish Matte Tin Annealed over Copper Leadframe.
 Solderable per MIL-STD-202, Method 208 [®]
- Weight: 0.33 grams (Approximate)

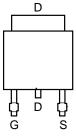
Applications

Switching

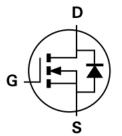




Top View



Top View



Internal Schematic

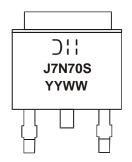
Ordering Information (Note 4)

Part Number	Compliance	Case	Packaging
DMJ7N70SK3-13	Standard	TO252 (DPAK)	2,500/Tape & Reel

Notes:

- 1. EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant. All applicable RoHS exemptions applied.
- See http://www.diodes.com/quality/lead_free.html for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. For packaging details, go to our website at http://www.diodes.com/products/packages.html.

Marking Information



☐ HManufacturer's Marking

J7N70S = Product Type Marking Code

YYWW = Date Code Marking

YY = Last Two Digits of Year (ex: 17 = 2017)

WW = Week Code (01 to 53)



Maximum Ratings (@ $T_A = +25^{\circ}C$, unless otherwise specified.)

Characteristic	Symbol	Value	Unit
Drain-Source Voltage	V _{DSS}	700	V
Gate-Source Voltage	V_{GSS}	±30	V
Continuous Drain Current (Note 5) V _{GS} = 10V	I _D	3.9 2.5	А
Maximum Body Diode Forward Current (Note 5)	Is	3.0	Α
Pulsed Drain Current (10µs Pulse, Duty Cycle = 1%)	I _{DM}	8.0	Α
Avalanche Current (Note 6)	I _{AR}	1.5	Α
Avalanche Energy (Note 6)	E _{AR}	67	mJ
Peak Diode Recovery dv/dt	dv/dt	11.8	V/ns

Thermal Characteristics (@TA = +25°C, unless otherwise specified.)

Characteristic	Symbol	Value	Unit	
Total Power Dissipation (Note 5)	$T_C = +25$ °C	D-	28	- W
Total Power Dissipation (Note 5)	T _C = +100°C	P_{D}	11	
Thermal Resistance, Junction to Ambient (Note 5)		R _{0JA}	38	°C/W
Thermal Resistance, Junction to Case (Note 5)		R _{0JC}	2.1	C/VV
Operating and Storage Temperature Range	T _{J,} T _{STG}	-55 to +150	°C	

Electrical Characteristics (@T_A = +25°C, unless otherwise specified.)

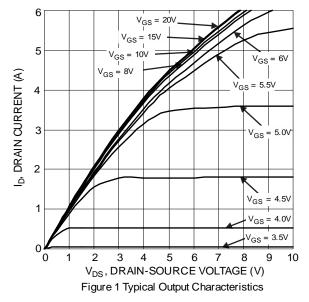
Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition	
OFF CHARACTERISTICS (Note 7)							
Drain-Source Breakdown Voltage	BV _{DSS}	700	_	_	V	$V_{GS} = 0V, I_D = 250\mu A$	
Zero Gate Voltage Drain Current	I _{DSS}	_	_	1	μA	$V_{DS} = 700V, V_{GS} = 0V$	
Gate-Source Leakage	I _{GSS}	_	_	100	nA	$V_{GS} = \pm 30V, V_{DS} = 0V$	
ON CHARACTERISTICS (Note 7)	ON CHARACTERISTICS (Note 7)						
Gate Threshold Voltage	V _{GS(TH)}	2	2.9	4	V	$V_{DS} = V_{GS}$, $I_D = 250\mu A$	
Static Drain-Source On-Resistance	R _{DS(ON)}	_	1	1.25	Ω	$V_{GS} = 10V, I_D = 2.5A$	
Diode Forward Voltage	V _{SD}	_	0.9	1.3	V	$V_{GS} = 0V, I_{S} = 5A$	
DYNAMIC CHARACTERISTICS (Note 8)						·	
Input Capacitance	C _{iss}		351	_			
Output Capacitance	Coss		66	_	pF	$V_{DS} = 50V, f = 1MHz,$ $V_{GS} = 0V$	
Reverse Transfer Capacitance	C _{rss}	_	1.1	_		VGS = UV	
Gate Resistance	R _G	_	3.5	_	Ω	$V_{DS} = 0V$, $V_{GS} = 0V$, $f = 1MHz$	
Total Gate Charge	Qg	_	13.9	_		V 500V I 54	
Gate-Source Charge	Qgs	_	1.9	_	nC	$V_{DD} = 560V, I_{D} = 5A,$ $V_{GS} = 10V$	
Gate-Drain Charge	Q _{gd}	_	8.5	_			
Turn-On Delay Time	t _{D(ON)}	_	8.5	_			
Turn-On Rise Time	t _R	_	11.6	_	ns	$V_{DD} = 350V, V_{GS} = 10V,$ $R_G = 4.7\Omega, I_D = 2.5A$	
Turn-Off Delay Time	t _{D(OFF)}	_	24.5	_	115		
Turn-Off Fall Time	t _F		10	_			
Body Diode Reverse Recovery Time	t _{RR}	_	212	_	ns	V _{DD} = 100V, I _S = 5A,	
Body Diode Reverse Recovery Time (T _J = +150°C)	t _{RR}	_	251	_	ns		
Body Diode Reverse Recovery Charge	Q _{RR}	_	1.8	_	μC		
Body Diode Reverse Recovery Charge (T _J = +150°C)	Q _{RR}	_	2.3	_	μC		

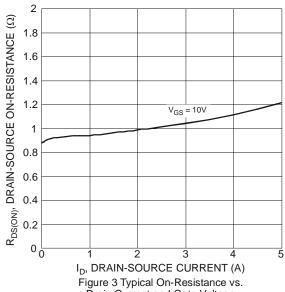
Notes: 5. Device mounted on FR-4 substrate PC board, 2oz copper, with 1inch square copper pad layout.

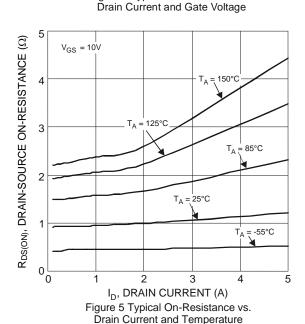
- 6. UIS in production with V_{DD} = 50V, V_{GS} = 10V, L = 60mH, T_J = +25°C.
- 7. Short duration pulse test used to minimize self-heating effect.
- 8. Guaranteed by design. Not subject to production testing.

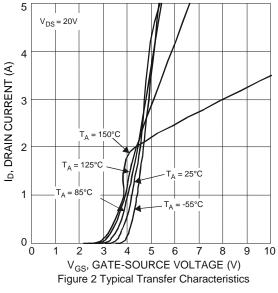


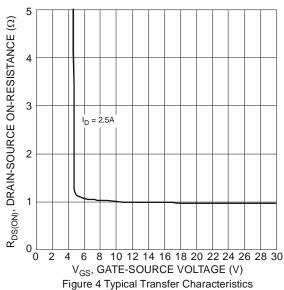












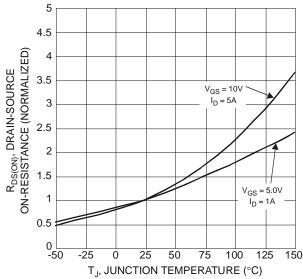
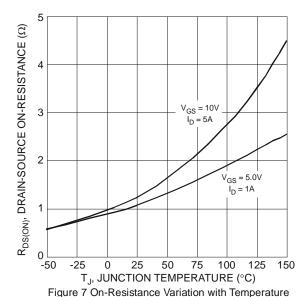
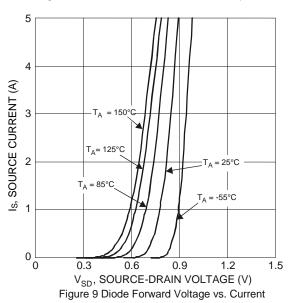
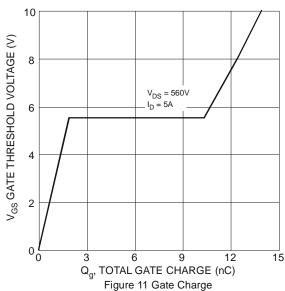


Figure 6 On-Resistance Variation with Temperature









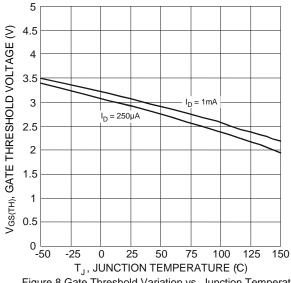
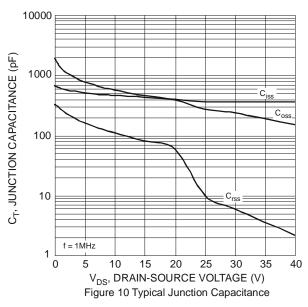


Figure 8 Gate Threshold Variation vs. Junction Temperature



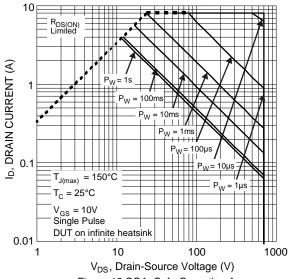


Figure 12 SOA, Safe Operation Area



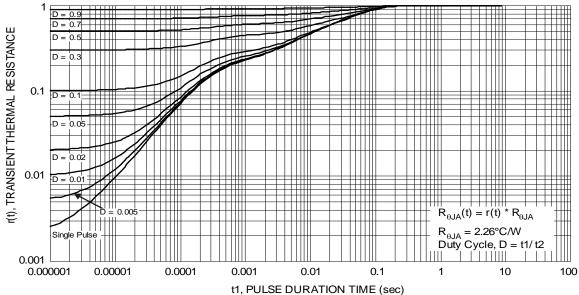
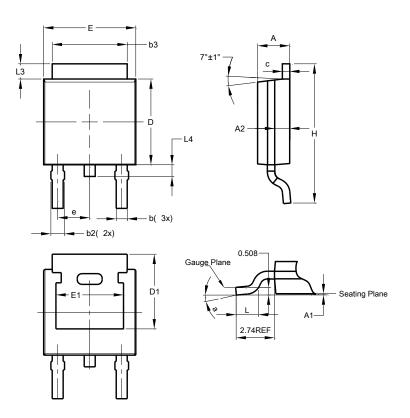


Figure 13 Transient Thermal Resistance



Package Outline Dimensions

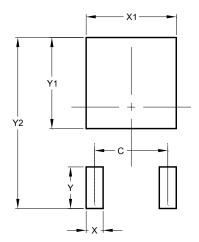
Please see http://www.diodes.com/package-outlines.html for the latest version.



TO252 (DPAK)					
Dim	Min	Max	Тур		
Α	2.19	2.39	2.29		
A1	0.00	0.13	0.08		
A2	0.97	1.17	1.07		
b	0.64	0.88	0.783		
b2	0.76	1.14	0.95		
b3	5.21	5.46	5.33		
C	0.45	0.58	0.531		
D	6.00	6.20	6.10		
D1	5.21	-	-		
е	-	-	2.286		
Е	6.45	6.70	6.58		
E1	4.32	-	-		
Н	9.40	10.41	9.91		
L	1.40	1.78	1.59		
L3	0.88	1.27	1.08		
L4	0.64	1.02	0.83		
а	0°	10°	-		
All Dimensions in mm					

Suggested Pad Layout

Please see http://www.diodes.com/package-outlines.html for the latest version.



Dimensions	Value (in mm)		
С	4.572		
Х	1.060		
X1	5.632		
Y	2.600		
Y1	5.700		
Y2	10.700		



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